Notice of References Cited Application/Control No. 10/608,093 Examiner TRUNG DIEP Applicant(s)/Patent Under Reexamination WATANABE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY	Ivanie	Classification
*	Α	US-6,919,920 B2	07-2005	Squilla et al.	348/207.99
*	В	US-6,956,599 B2	10-2005	Lim et al.	348/14.02
*	O	US-5,806,005	09-1998	Hull et al.	455/566
*	D	US-6,373,842 B1	04-2002	Coverdale et al.	370/394
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.